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Sheet 1 of 1 U.S. DEPARTMENT OF COMMENTY, DOCKET NO. PATENT AND TRADEMARK OFFINE P-256-03 SERIAL NO. 10/807,156 FORM PTO-1449 (REV. 7-80) APPLICANT LIST OF DOCUMENTS CITED BY APPLICANT K. ANAZAWA et al (Use several sheets if nacessary) GROUP FILING DATE 1754 March 24, 2004 U.S. PATENT DOCUMENTS FILING DATE SUBCLAS CLASS (If Appropriate NAME EXAMINE DATE DOCUMENT 18 588 J. HANULIK 01/31/95 A5,386,078 27 68 H. GRUNEWALD 10/23/84 4,478,060 FOREIGN PATENT DOCUMENTS TRANSLATION SUBCLAS CLASS COUNTRY NO YES DATE DOCUMENT \boxtimes CANADA 07/14/87 1224025 F : OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.) DATE CONSIDERED -06 EXAMINER of not created to the contromance with MPEP 809; Oraw line through claster til not to conformance and not considered, include copy of this form as EXAMINER: Intelligence consider

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